IRFDC20

Vishay Siliconix



HVMDIP

PRODUCT SUMMARY

V_{DS} (V)

R_{DS(on)} (Ω)

Q_{as} (nC)

Q_{gd} (nC)

Q_a (Max.) (nC)

Configuration

Power MOSFET

s

N-Channel MOSFET

4.4

600

18

3.0

8.9

Single

V_{GS} = 10 V

FEATURES

- Dynamic dV/dt rating
- Repetitive avalanche rated
- For automatic insertion
- End stackable
- Fast switching
- Ease of paralleling
- Simple drive requirements
- Material categorization: for definitions of compliance please see <u>www.vishay.com/doc?99912</u>

DESCRIPTION

Third generation power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The 4 pin DIP package is a low cost machine-insertable case style which can be stacked in multiple combinations on standard 0.1" pin centers. The dual drain serves as a thermal link to the mounting surface for power dissipation levels up to 1 W.

ORDERING INFORMATION	
Package	HVMDIP
Lead (Pb)-free	IRFDC20PbF

ABSOLUTE MAXIMUM RATINGS (TA	= 25 °C, unle	ess otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-source voltage			V _{DS}	600	- V	
Gate-source voltage			V _{GS}	± 20		
Continuous drain current	V _{GS} at -10 V	T _A = 25 °C		0.32		
Continuous drain current	V _{GS} at -10 V	T _A = 100 °C	I _D	0.20	А	
Pulsed drain current ^a			I _{DM}	2.6	1	
Linear derating factor				0.0083	W/°C	
Single pulse avalanche energy ^b			E _{AS}	50	mJ	
Repetitive avalanche current ^a			I _{AR}	0.32	A	
Repetitive avalanche energy ^a			E _{AR}	0.10	mJ	
Maximum power dissipation $T_A = 25 \text{ °C}$		PD	1.0	W		
Peak diode recovery dv/dt ^c			dV/dt	3.0	V/ns	
Operating junction and storage temperature range		T _J , T _{stg}	- 55 to + 150	- °C		
Soldering rRecommendations (peak temperature) d For 10 s			300 ^d			

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)

b. $V_{DD} = 50$ V, starting $T_J = 25$ °C, L = 54 mH, $R_a = 25 \Omega$, $I_{AS} = 1.3$ A (see fig. 12)

c. $I_{SD} \le 4.4$ A, dl/dt ≤ 90 A/µs, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C

d. 1.6 mm from case

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THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	120	°C/W	

PARAMETER	SYMBOL	TES	T CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	= 0 V, I _D = 250 μA	600	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	Reference	e to 25 °C, I _D = 1 mA	-	0.88	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}		V _{GS} = ± 20 V	-	-	± 100	nA
		$V_{DS} = 600 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$		-	-	25	
Zero Gate Voltage Drain Current	IDSS	V _{DS} = 480V	$V_{DS} = 480V, V_{GS} = 0 V, T_{J} = 125 \text{ °C}$		-	250	μA
Drain-Source On-State Resistance	R _{DS(on)}	$V_{GS} = 10 V$	I _D = 0.19 A ^b	-	-	4.4	Ω
Forward Transconductance	g fs	V _{DS} =	V _{DS} = 50 V, I _D = 1.3 A ^b		-	-	S
Dynamic							•
Input Capacitance	C _{iss}	$V_{GS} = 0 V$,		-	350	-	pF
Output Capacitance	C _{oss}	_	$V_{GS} = 0 V,$ $V_{DS} = 25 V,$		48	-	
Reverse Transfer Capacitance	C _{rss}	f = 1.0 MHz, see fig. 5		-	8.6	-	
Total Gate Charge	Qg			-	-	18	
Gate-Source Charge	Q_gs	V _{GS} = 10 V	I _D = 2.0 A, V _{DS} = 360 V, see fig.6 and 13 ^b	-	-	3.0	nC
Gate-Drain Charge	Q _{gd}		see lig.o and to	-	-	8.9	
Turn-On Delay Time	t _{d(on)}			-	10	-	
Rise Time	t _r		$V_{DD} = 300 \text{ V}, \text{ I}_{D} = 2.0 \text{ A},$		23	-	- ns
Turn-Off Delay Time	t _{d(off)}	$R_g = 18 \ Ω$, $R_D = 150 \ Ω$, see fig. 10^b		-	30	-	
Fall Time	t _f			-	25	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.0	-	
Internal Source Inductance	L _S			-	6.0	-	nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the		-	-	0.32	А
Pulsed Diode Forward Current ^a	I _{SM}	integral revers p - n junction		-	-	2.6	
Body Diode Voltage	V_{SD}	T _J = 25 °C,	$I_{S} = 0.32$ A, $V_{GS} = 0$ V ^b	-	-	1.6	V
Body Diode Reverse Recovery Time	t _{rr}	T _{.J} = 25 °C, I _F = 2.0 A, dl/dt = 100 A/µs ^b		-	290	580	ns
Body Diode Reverse Recovery Charge	Q _{rr}	$J = 25 \text{ C}, I_{\text{F}}$	$= 2.0 \text{ A}, \text{ u/ul} = 100 \text{ A/} \text{µS}^{5}$	-	0.67	1.3	μC
Forward Turn-On Time	t _{on}	Intrinsic tu	rn-on time is negligible (turn	-on is dor	minated b	y L _S and	L _D)

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)

b. Pulse width \leq 300 µs; duty cycle \leq 2 %

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TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

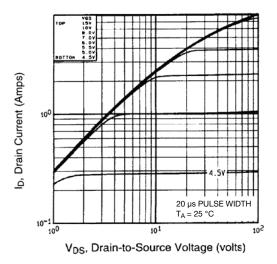


Fig. 1 - Typical Output Characteristics, T_A = 25 °C

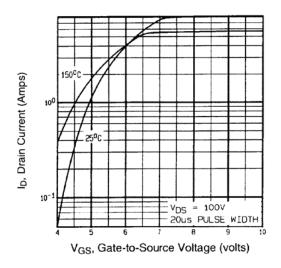


Fig. 3 - Typical Transfer Characteristics

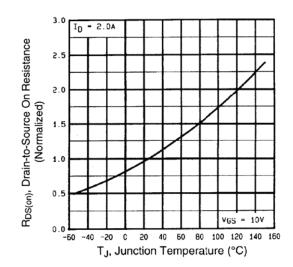


Fig. 4 - Normalized On-Resistance vs. Temperature

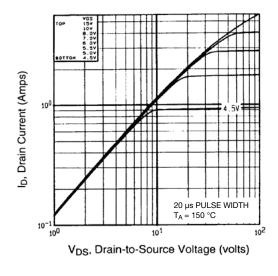


Fig. 2 - Typical Output Characteristics, T_A = 150 °C



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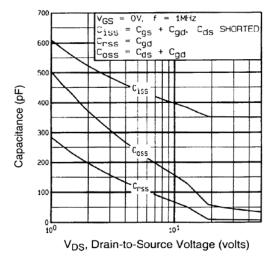
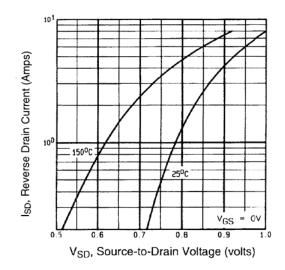
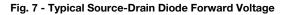


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage





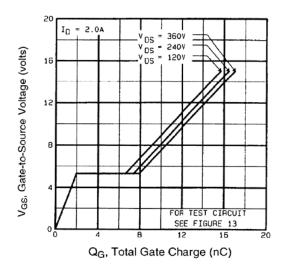
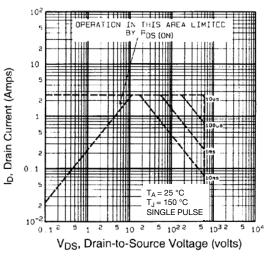
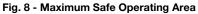


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage









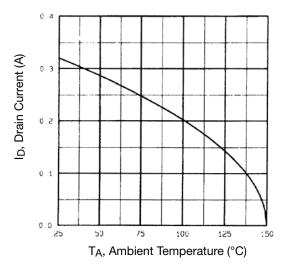


Fig. 9 - Maximum Drain Current vs. Ambient Temperature

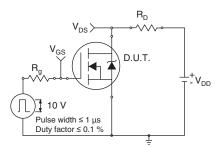


Fig. 10a - Switching Time Test Circuit

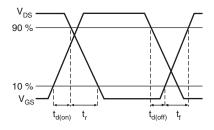


Fig. 10b - Switching Time Waveforms

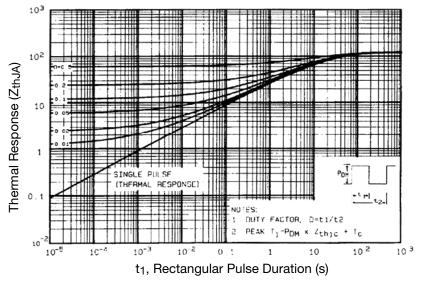


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Ambient



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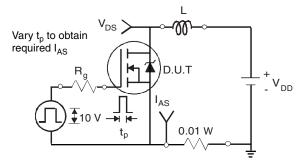


Fig. 12a - Unclamped Inductive Test Circuit

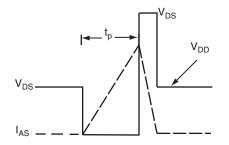


Fig. 12b - Unclamped Inductive Waveforms

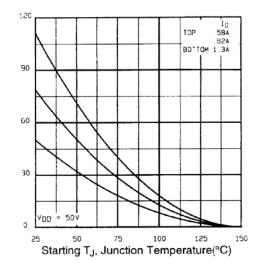
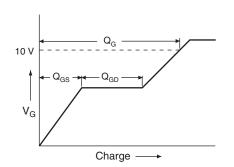


Fig. 12c - Maximum Avalanche Energy vs. Drain Current





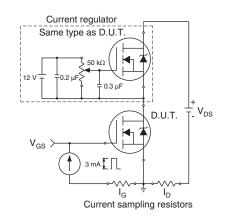


Fig. 13b - Gate Charge Test Circuit

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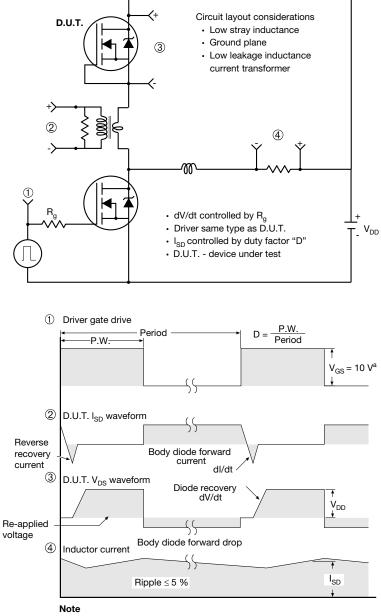
Document Number: 91142

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Peak Diode Recovery dV/dt Test Circuit



a. V_{GS} = 5 V for logic level devices

Fig. 14 - For N-Channel

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HVM DIP (High voltage)





	INCHES		MILLIN	IETERS
DIM.	MIN.	MAX.	MIN.	MAX.
А	0.310	0.330	7.87	8.38
E	0.300	0.425	7.62	10.79
L	0.270	0.290	6.86	7.36
ECN: X10-0386-Rev. B, 0 DWG: 5974	06-Sep-10			

Note

1. Package length does not include mold flash, protrusions or gate burrs. Package width does not include interlead flash or protrusions.



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